L Number	Hits	Search Text	DB	Time stamp
-	2	"6472236"	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/13 14:48
-	2791	((257/48) or (438/14-15)).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/13 14:48
-	1496	(((257/48) or (438/14-15)).CCLS.) and (low k)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/13 14:48
-	44	(((257/48) or (438/14-15)).CCLS.) and (low with k)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/13 15:01
-	13	("5266525" | "5567655" | "5637186" | "5788767" | "5998226" | "6028324" | "6046102" | "6093620" | "6191036" | "6246075" | "6248661" | "6291254" | "6479404").PN.	USPAT	2004/04/13 14:54
-	109	(((257/48) or (438/14-15)).CCLS.) and (crack$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/13 15:42
-	108	((((257/48) or (438/14-15)).CCLS.) and (crack$1)) not (((((257/48) or (438/14-15)).CCLS.) and (low with k))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/13 15:02
-	0	(((257/48) or (438/14-15)).CCLS.) and (crack$5 with test$5).in.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/13 15:43
-	0	(((257/48) or (438/14-15)).CCLS.) and (crack$5 with test$5).ti.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/13 15:43
-	22	(((257/48) or (438/14-15)).CCLS.) and (crack$5 with test$5)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/13 15:45
-	8	((((257/48) or (438/14-15)).CCLS.) and (crack$5 with test$5)) not ((((((257/48) or (438/14-15)).CCLS.) and (crack$1)) not (((((257/48) or (438/14-15)).CCLS.) and (low with k)))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/13 15:44
-	7966	((438/14-15) or (438/404) or (257/48) or (257/414-415) or (257/417) or (257/467) or (257/469) or (257/528) or (257/632-635) or (257/798)).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/13 15:45
-	0	(((438/14-15) or (438/404) or (257/48) or (257/414-415) or (257/417) or (257/467) or (257/469) or (257/528) or (257/632-635) or (257/798)).CCLS.) and (crack$5 with test$5).ti.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/13 16:57
-	39	(((438/14-15) or (438/404) or (257/48) or (257/414-415) or (257/417) or (257/467) or (257/469) or (257/528) or (257/632-635) or (257/798)).CCLS.) and (crack$5 with test$5)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/13 15:51

-	17	((((438/14-15) or (438/404) or (257/48) or (257/414-415) or (257/417) or (257/467) or (257/469) or (257/528) or (257/632-635) or (257/798)).CCLS.) and (crack$5 with test$5)) not ((((257/48) or (438/14-15)).CCLS.) and (crack$5 with test$5))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/13 15:50
-	3	("6605868").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/13 15:50
-	38	(((438/14-15) or (438/404) or (257/48) or (257/414-415) or (257/417) or (257/467) or (257/469) or (257/528) or (257/632-635) or (257/798)).CCLS.) and (crack$5 with (measur$5 or monitor$5 or record$5 or observ$5))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/13 16:57
-	28	((((438/14-15) or (438/404) or (257/48) or (257/414-415) or (257/417) or (257/467) or (257/469) or (257/528) or (257/632-635) or (257/798)).CCLS.) and (crack$5 with (measur$5 or monitor$5 or record$5 or observ$5))) not ((((438/14-15) or (438/404) or (257/48) or (257/414-415) or (257/417) or (257/467) or (257/469) or (257/528) or (257/632-635) or (257/798)).CCLS.) and (crack$5 with test$5))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/13 15:52
-	22	(crack$5 with (test$5 or measur$5 or monitor$5 or record$5 or observ$5)).ti. and dielectric	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/13 17:22
-	201	(crack$5 with (test$5 or measur$5 or monitor$5 or record$5 or observ$5)).ab. and dielectric	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/14 10:43
-	2457	(crack$5 with (test$5 or measur$5 or monitor$5 or record$5 or observ$5)) and dielectric	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/14 10:41
-	2238	(crack$5 with (test$5 or measur$5 or monitor$5 or observ$5)) and dielectric	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/14 10:42
-	324	((crack$5 with (test$5 or measur$5 or monitor$5 or observ$5)) same stress) and dielectric	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/14 10:42
-	201	(crack$5 with (test$5 or measur$5 or monitor$5 or record$5 or observ$5)).ab. and dielectric	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/14 10:44
-	324	(((crack$5 with (test$5 or measur$5 or monitor$5 or observ$5)) same stress) and dielectric) not US-20040062700-A1.DID.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/04/14 10:44
-	8	("5096855" | "5530280" | "5650348" | "5665655" | "5789302" | "6100589" | "6365958" | "6372661").PN.	USPAT	2004/04/14 10:53